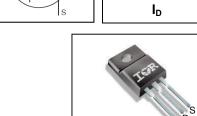
HEXFET® Power MOSFET



- · Logic -Level Gate Drive
- Advanced Process Technology
- Isolated Package
- High Voltage Isolation = 2.5KVRMS ⑤
- Sink to Lead Creepage Dist. = 4.8mm
- Fully Avalanche Rated
- Lead-Free

# G

V <sub>DSS</sub>	55V
R <sub>DS(on)</sub>	0.022Ω
I <sub>D</sub>	30A



TO-220 Full-Pak

G	D	S
Gate	Drain	Source

# **Description**

Fifth Generation HEXFETs from International Rectifier utilize advanced processing techniques to achieve extremely low on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET Power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in a wide variety of applications.

The TO-220 Full Pak eliminates the need for additional insulating hardware in commercial-industrial applications. The molding compound used provides a high isolation capability and a low thermal resistance between the tab and external heat sink. This isolation is equivalent to using a 100 micron mica barrier with standard TO-220 product. The Fullpak is mounted to a heat sink using a single clip or by a single screw fixing.

Base Part Number Package Type		Standar	Orderable Bort Number	
base Part Number	Package Type	Form	Quantity	Orderable Part Number
IRLIZ44NPbF	TO-220 Full-Pak	Tube	50	IRLIZ44NPbF

Absolute Maximum Ratings						
Symbol	Parameter	Max.	Units			
I <sub>D</sub> @ T <sub>C</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	30				
<sub>D</sub> @ T <sub>C</sub> = 100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V	22	Α			
DM	Pulsed Drain Current ①⑥	160				
P <sub>D</sub> @T <sub>C</sub> = 25°C	Maximum Power Dissipation	45	W			
	Linear Derating Factor	0.3	W/°C			
$V_{GS}$	Gate-to-Source Voltage	± 16	V			
E <sub>AS</sub>	Single Pulse Avalanche Energy (Thermally Limited) ②⑥	210	mJ			
AR	Avalanche Current ①⑥	25	А			
= AR	Repetitive Avalanche Energy ①⑥	4.5	mJ			
dv/dt	Peak Diode Recovery dv/dt36	5.0	V/ns			
Γ <sub>J</sub>	Operating Junction and	-55 to + 175				
$\Gamma_{ m STG}$	Storage Temperature Range		°C			
	Soldering Temperature, for 10 seconds (1.6mm from case)	300				
	Mounting torque, 6-32 or M3 screw	10 lbf•in (1.1N•m)				

### Thermal Resistance

Symbol	Parameter	Тур.	Max.	Units
$R_{ heta JC}$	Junction-to-Case		3.3	°C/W
$R_{ heta JA}$	Junction-to-Ambient		65	C/VV

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# Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions		
V <sub>(BR)DSS</sub>	Drain-to-Source Breakdown Voltage	55			V	$V_{GS} = 0V, I_D = 250\mu A$		
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		0.070		V/°C	Reference to 25°C, I <sub>D</sub> = 1mA 6		
, ,				0.022		V <sub>GS</sub> = 10V, I <sub>D</sub> = 17A		
R <sub>DS(on)</sub>	Static Drain-to-Source On-Resistance			0.025	Ω	V <sub>GS</sub> = 5.0V, I <sub>D</sub> = 17A		
23(61.)				0.035		V <sub>GS</sub> = 4.0V, I <sub>D</sub> = 14A		
$V_{GS(th)}$	Gate Threshold Voltage	1.0		2.0	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$		
gfs	Forward Trans conductance	21			1	V <sub>DS</sub> = 25V, I <sub>D</sub> = 25A®		
	Drain to Source Leakage Current			25	μA	$V_{DS} = 55V, V_{GS} = 0V$		
I <sub>DSS</sub>	Drain-to-Source Leakage Current			250	μΑ	$V_{DS} = 44V, V_{GS} = 0V, T_{J} = 150^{\circ}C$		
1	Gate-to-Source Forward Leakage			100	nA	V <sub>GS</sub> = 16V		
I <sub>GSS</sub>	Gate-to-Source Reverse Leakage			-100	IIA	$V_{GS} = -16V$		
$Q_g$	Total Gate Charge			48		I <sub>D</sub> = 25A		
$Q_{gs}$	Gate-to-Source Charge			8.6	nC	V <sub>DS</sub> = 44V		
$Q_{gd}$	Gate-to-Drain Charge			25		V <sub>GS</sub> = 5.0V , See Fig. 6 and 13④⑥		
t <sub>d(on)</sub>	Turn-On Delay Time		11			$V_{DD} = 28V$		
t <sub>r</sub>	Rise Time		84			I <sub>D</sub> = 25A		
t <sub>d(off)</sub>	Turn-Off Delay Time		26		ns	$R_G = 3.4\Omega, V_{GS} = 5.0V$		
t <sub>f</sub>	Fall Time		15			R <sub>D</sub> = 1.1Ω, See Fig. 10④⑥		
L <sub>D</sub>	Internal Drain Inductance		4.5			Between lead, 6mm (0.25in.)		
Ls	Internal Source Inductance		7.5		ПП	from package and center of die contact		
C <sub>iss</sub>	Input Capacitance		1700			V <sub>GS</sub> = 0V		
C <sub>oss</sub>	Output Capacitance		400		مر [	V <sub>DS</sub> = 25V		
C <sub>rss</sub>	Reverse Transfer Capacitance		150		pF	f = 1.0MHz, See Fig. 5®		
С	Drain to Sink Capacitance		12			f = 1.0MHz		

# **Source-Drain Ratings and Characteristics**

<u> </u>	rum rumgo una onaraoteriotico					
	Parameter	Min.	Тур.	Max.	Units	Conditions
I <sub>S</sub>	Continuous Source Current (Body Diode)			30		MOSFET symbol showing the
I <sub>SM</sub>	Pulsed Source Current (Body Diode) ① ⑤			160		integral reverse p-n junction diode.
$V_{SD}$	Diode Forward Voltage			1.3	V	$T_J = 25^{\circ}C, I_S = 17A, V_{GS} = 0V $ ④
t <sub>rr</sub>	Reverse Recovery Time		80	120	ns	T <sub>J</sub> = 25°C ,I <sub>F</sub> = 25A
Q <sub>rr</sub>	Reverse Recovery Charge		210	320	nC	di/dt = 100A/µs ④⑥
t <sub>on</sub>	Forward Turn-On Time	Intrinsio	Intrinsic turn-on time is negligible (turn-on is dominated by L <sub>S</sub> +L <sub>D</sub> )			

# Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)
- ②  $V_{DD}$  =25V, Starting  $T_J$  = 25°C, L = 470 $\mu$ H,  $R_G$  = 25 $\Omega$ ,  $I_{AS}$  = 25A (See fig. 12)
- $\label{eq:local_state} \mbox{ } \mbo$
- ⑤ t=60s, *f*=60Hz
- © Uses IRLZ44N data and test conditions.

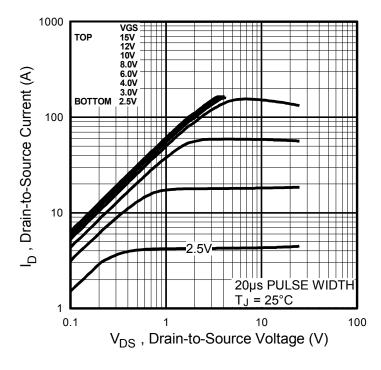


Fig. 1 Typical Output Characteristics

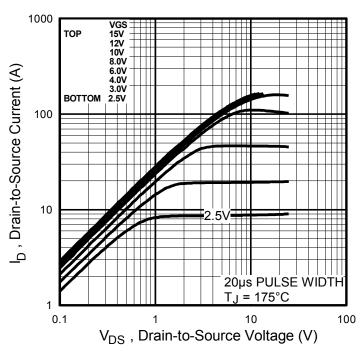


Fig. 2 Typical Output Characteristics

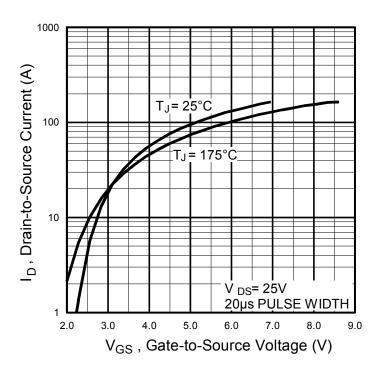
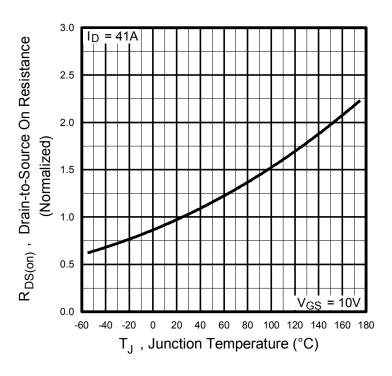
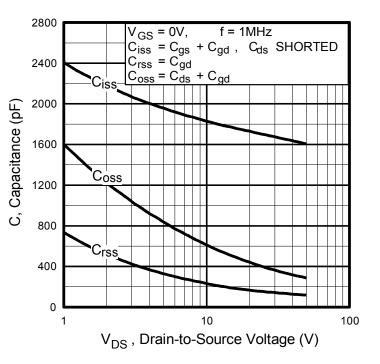


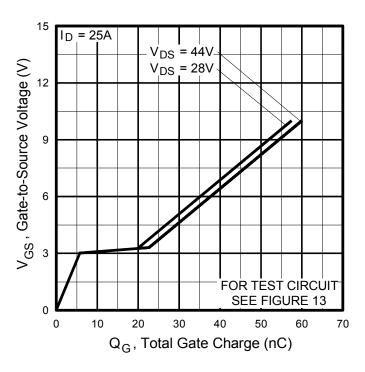
Fig. 3 Typical Transfer Characteristics



**Fig. 4** Normalized On-Resistance vs. Temperature



**Fig 5.** Typical Capacitance vs. Drain-to-Source Voltage



**Fig 6.** Typical Gate Charge vs. Gate-to-Source Voltage

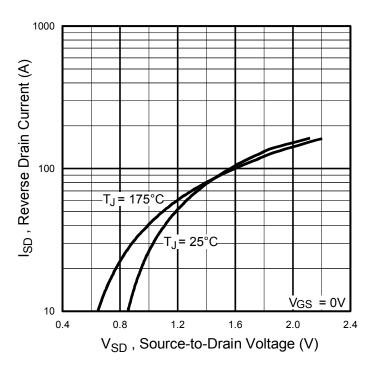


Fig. 7 Typical Source-to-Drain Diode Forward Voltage

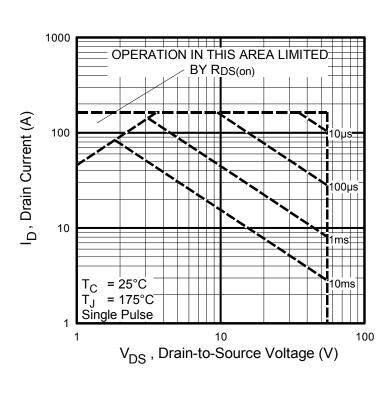


Fig 8. Maximum Safe Operating Area

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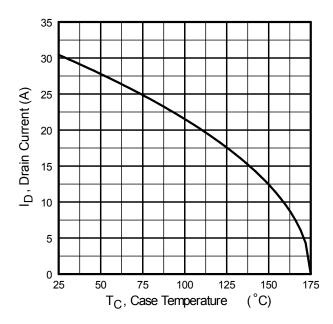


Fig 9. Maximum Drain Current vs. Case Temperature

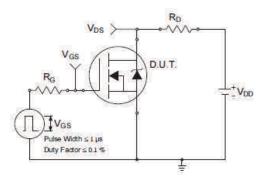


Fig 10a. Switching Time Test Circuit

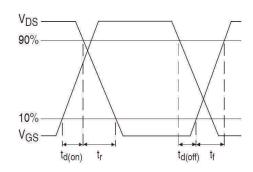


Fig 10b. Switching Time Waveforms

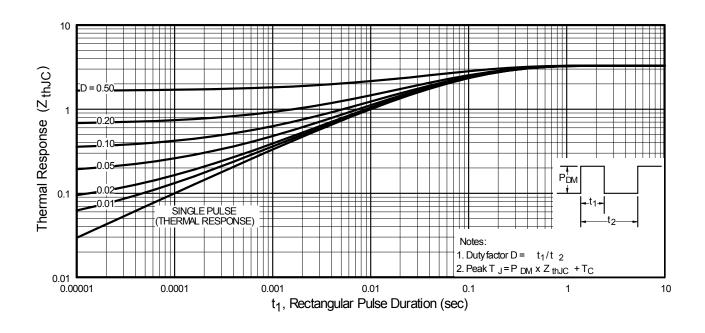


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case



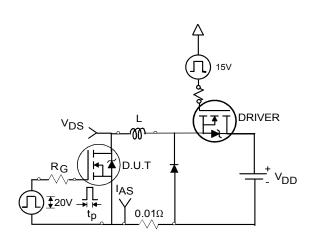


Fig 12a. Unclamped Inductive Test Circuit

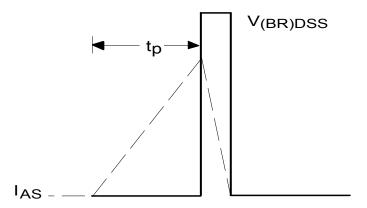


Fig 12b. Unclamped Inductive Waveforms

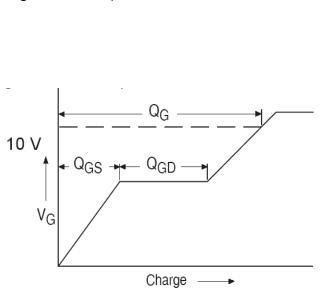
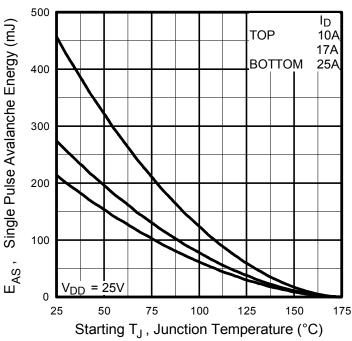


Fig 13a. Gate Charge Waveform



**Fig 12c.** Maximum Avalanche Energy vs. Drain Current

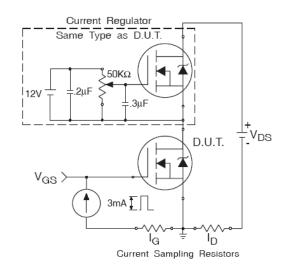
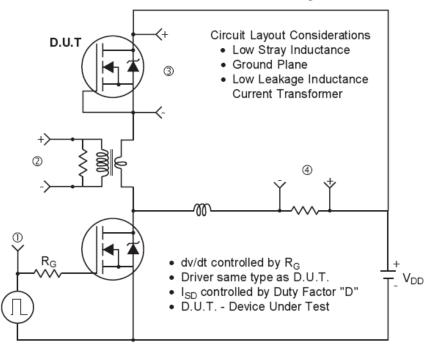


Fig 13b. Gate Charge Test Circuit

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# Peak Diode Recovery dv/dt Test Circuit



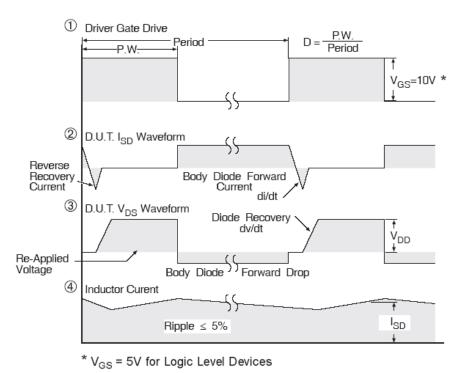
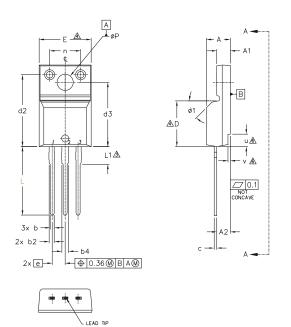
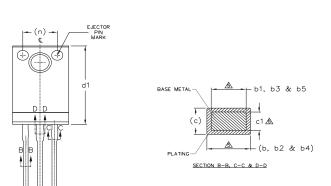


Fig 14. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs



# TO-220 Full-Pak Package Outline (Dimensions are shown in millimeters (inches))





#### NOTES:

- 1.0 DIMENSIONING AND TOLERANCING AS PER ASME Y14.5 M- 1994.
- 2,0 DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].

么 LEAD DIMENSION AND FINISH UNCONTROLLED IN L1.

DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005" (0.127) PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTER MOST EXTREMES OF THE PLASTIC BODY.

DIMENSION 61, 63, 65 & c1 APPLY TO BASE METAL ONLY.

6.0 STEP OPTIONAL ON PLASTIC BODY DEFINED BY DIMENSIONS u & v.

7.0 CONTROLLING DIMENSION: INCHES.

S		DIMEN	SIONS		N	
M B	MILLIM	ETERS	INC	HES	0 <u>T</u>	
O L	MIN.	MAX.	MIN.	MAX.	T E S	
A A1 A2 b b1 b2 b3 b4 b5 c c1 D d1 d2 d3 E e L L1 n ØP u v	4.57 2.57 2.51 0.61 0.76 0.76 1.02 1.02 0.33 0.33 8.66 15.80 13.97 12.29 9.63 2.54 13.21 3.10 6.05 3.05 2.39 0.41	4.83 2.82 2.92 0.94 0.89 1.27 1.22 1.52 1.47 0.63 0.58 9.80 16.13 14.22 12.93 10.74 BSC 13.72 3.68 6.60 3.45 2.49 0.51	.180 .101 .099 .024 .030 .030 .040 .013 .013 .341 .622 .550 .484 .379 .100 .520 .122 .238 .120 .094	.190 .111 .115 .037 .035 .050 .048 .060 .058 .025 .023 .386 .635 .560 .509 .423 BSC .540 .145 .260 .136 .098	5 5 5 5 4 4 3	LEAD ASSIGNMENTS  HEXFET  1.— GATE  2.— DRAIN  3.— SOURCE  IGBTS, CoPACK  1.— GATE  2.— COLLECTOR  3.— EMITTER
ø1	_	45°	_	45°		

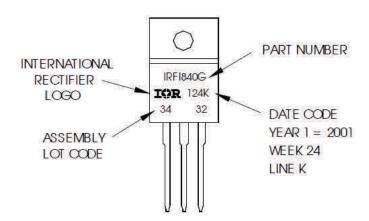
### TO-220 Full-Pak Part Marking Information

EXAMPLE: THIS IS AN IRFI840G WITH ASSEMBLY

LOT CODE 3432

ASSEMBLED ON WW 24, 2001 IN THE ASSEMBLY LINE "K"

Note: "P" in assembly line position indicates "Lead-Free"



TO-220AB Full-Pak packages are not recommended for Surface Mount Application.

Note: For the most current drawing please refer to website at http://www.irf.com/package/



#### **Qualification Information**

Qualification Level	Industrial (per JEDEC JESD47F) †						
Moisture Sensitivity Level	TO-220 Full-Pak N/A						
RoHS Compliant	Yes						

† Applicable version of JEDEC standard at the time of product release.

# **Revision History**

Date	Comments
04/27/2017	<ul> <li>Changed datasheet with Infineon logo - all pages.</li> <li>Corrected Package Outline on page 8.</li> <li>Added disclaimer on last page.</li> </ul>

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